

Notice of References Cited

Application/Control No. 09/452,802 Examiner 2631 **Emmanuel Bayard**

Applicant(s)/Patent Under Reexamination ANVEKAR ET AL.

Art Unit

Page 1 of 1

U.S. PATENT DOCUMENTS

*	£	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,031,864	02-2000	Bauchot et al.	375/133
	В	US-6,424,820	07-2002	Burdick et al.	455/41.1
	С	US-6,295,310	09-2001	Yamauchi et al.	375/133
	D	US-5,394,433	02-1995	Bantz et al.	375/132
	Ε	US-5,276,686	01-1994	Ito, Koichi	370/330
	F	US-2001/0040878	11-2001	Schilling, Donald L.	370/329
	G	US-6,587,444	07-2003	Lenzo et al.	370/330
	Н	US-5,781,582	07-1998	Sage et al.	375/134
	ı	US-5,914,947	06-1999	Saito, Naritoshi	370/337
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	٧	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.